Notice of References Cited

Application/Control No.
09/963,465
Examiner

Yvette C. Thornton

Applicant(s)/Patent Under Reexamination HASEGAWA ET AL.

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,985,524 A	11-1999	Allen et al.	430/326
	В	US-6,444,408 B1	09-2002	Brock et al.	430/322
	С	US-5,580,694 A	12-1996	Allen et al.	430/270.1
	D	US-6,045,970 A	04-2000	Choi, Sang-jun	430/270.1
	Ε	US-6,506,535 B1	01-2003	Mizutani et al.	430/270.1
	F	US-6,210,856 B1	04-2001	Lin et al.	430/270.1
	G	US-6,165,682 A	12-2000	Foster et al.	430/270.1
	Н	US-6,103,448 A	08-2000	Kim et al.	430/270.1
	1	US-6,063,543 A 05-2000 Hien et al.		Hien et al.	430/270.1
	J	US-			430/270.1
	к	US-			
\exists	L	US-			
7	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
L	N	JP 2001166482 A	06-2001	Japan	MIZUTANI et al.	G03F 07/039
	0	JP 2001194787 A J	07-2001	Japan	SATO et al.	G03F 07/039
	Р	JP 2001194788 A	07-2001	Japan	SATO et al.	G03F 07/039
	Q	JP 2001194789 A	07-2001	Japan	SATO et al.	G03F 07/039
	R	JP 2001226432 A √	08-2001	Japan	HATAKEYAMA et al.	C08F 30/08
	s					
	Ţ					

NON-PATENT DOCUMENTS

	NON-FATENT DOCUMENTS
	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.